

<b>Notice of References Cited</b>	Application/Control No. 09/470,080	Applicant(s)/Patent Under Reexamination VANGAL ET AL.	
	Examiner Jamal A Fox	Art Unit 2664	Page 1 of 3

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Applicant(s)/Patent Under

Reexamination

VANGAL ET AL.

Examiner

Jamal A Fox

Art Unit

2664

Page 2 of 3

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	Examiner Jamal A Fox	Art Unit 2664	Page 3 of 3

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	I	US-			
	J	US-			
	K	US-			
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